

Application/Control No.	Applicant(s)/Patent under Reexamination STAKUTIS ET AL.	
09/687,668		
Examiner	Art Unit	
Thuy Pardo	2165	

SEARCHED					
Class	Subclass	Date	Examiner		
707	8 10 100	9/22/05	185		
	104.1				
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	INTERFERENCE SEARCHED					
Cla	ss	Subclass	Date	Examiner		
To	7	8	9/22/05	155		
	•	104.1				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
WEST IEEE	9/22/05	<i>1</i> 85	
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